



Agenda

Commemoration of 150 years of the Metro Convention

"150 years of comparable measurements in the world. Reflections on the past, present and future of metrology and the adoption and dissemination of the International System of Units (SI) in America"

Sistema Interamericano de Metrología (SIM) – Instituto Nacional de Metrología (INM)

May 8, 2025 - INM Auditorium

| Hora | Duración | Expositor |
|-----------------|----------|---|
| 08:00 - 08:10 h | 10 min | National anthem Event Setup |
| 08:10 - 08:20 h | 10 min | Welcome remarks Dr. Javier Arias President of the Inter-American System in Metrology |
| 08:20 - 08:30 h | 10 min | Welcome remarks Dr. María del Rosario González Márquez Director General of the National Institute of Metrology |
| 08:30 – 08:50 h | 30 min | Presentation: "Quality Infrastructure and Metrology as the Foundations of Scientific-Technological Based Enterprises" Pablo Angelelli Head of Operations at the Colombia Office of the Inter-American Development Bank |
| 08:50 - 09:20 h | 30 min | Virtual presentation: "The adoption of systems of weights and measures as a social fact" Héctor Vera Researcher at the National Autonomous University of Mexico |

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| 09:20 - 09:50 h | 30 min | <p>Presentation:</p> <p>"Balance, perspectives and challenges of the adoption of the International System of Units in the plastics, paints and chemicals sector"</p> <p>Daniel Mitchell – Executive President of Acoplásticos</p> |
| 09:50 – 10:20 h | 30 min | <i>Coffee break</i> |
| 10:20 – 10:50 h | 30 min | <p>Presentation:</p> <p>"Present and future of metrology"</p> <p>Lucas Di Lillo, President of the Technical Committee of the SIM (INTI / ARGENTINA)</p> |
| 10:50 – 11:20 h | 30 min | <p>Presentation</p> <p>"A Young Metrologist's Perspective on Metrology"</p> <p>Cristhian Paredes</p> <p>SIM winner of the best response to the International Bureau of Weights and Measures' "Young Metrologists Vision 2050+" survey</p> |
| 11:20 – 12:20 h | 60 min | <p>Panel: "Present and future of metrology: How to face the challenges of the adoption and dissemination of the International System of Units (SI)?"</p> <p>Javier Arias, President of the SIM</p> <p>Ferney Chaparro, Technical Secretary of IACC</p> <p>Daniel Trillos, COPANT Representative - Director of Standardization at ICONTEC</p> <p>Claudia Santo, Executive Secretary of the SIM</p> <p>Ramón Madriñan, Private Sector Representative</p> <p>Moderator: María del Rosario González, General Director of the INM</p> |
| 12:20 - 12:30 h | 10 min | Event Closing |